

STGE200NB60S

N-channel 150A - 600V - ISOTOP Low drop PowerMESH™ IGBT

General features

ТҮРЕ	V _{CES}	V _{CE(sat)} (typ.)	I _C	т _с
STGE200NB60S	600V	1.2V 1.3V	150A 200A	100°C 25°C

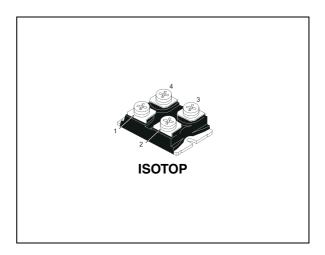
- High input impedance (voltage driven)
- Low on-voltage drop (Vcesat)
- Off losses include tail current
- Low gate charge
- High current capability

Description

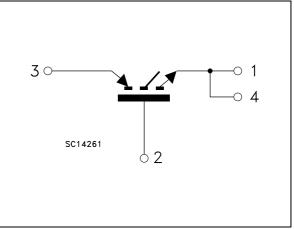
Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH[™] IGBTs, with outstanding performances. The suffix "S" identifies a family optimized to achieve very low VCE(sat) (@ max frequency of 1KHz).

Applications

- Low frequency motor controls
- Aluminum welding equipment



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STGE200NB60S	GE200NB60S	ISOTOP	Tube

November	2006

Contents

1	Electrical ratings	3
2	Electrical characteristics	4
	2.1 Electrical characteristics (curves)	6
3	Test circuit	9
4	Package mechanical data 1	0
5	Packaging mechanical data 1	4
6	Revision history1	5



1 Electrical ratings

Table 1. Absolute maximum ratings	•
-----------------------------------	---

Symbol	Parameter	Value	Unit
V _{CES}	Collector-emitter voltage ($V_{GS} = 0$)	600	V
V _{GE}	Gate-emitter voltage	±20	V
۱ _C	Collector current (continuous) at $T_C = 25^{\circ}C$	200	A
۱ _C	Collector current (continuous) at T _C = 100°C	150	A
I _{CM} ⁽¹⁾	Collector current (pulsed)	400	A
P _{TOT}	Total dissipation at $T_{C} = 25^{\circ}C$	600	W
	Derating factor	4.8	W/°C
V _{ISO}	Insulation winthstand voltage (DC)	2500	V
T _{stg}	Storage temperature	– 55 to 150	°C
Тj	Operating junction temperature	- 55 10 150	C

1. Pulse width limited by safe operating area

Table 2.Thermal resistance

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case max	0.208	°C/W °C/W
Rthj-amb	Thermal resistance junction-ambient max	30	°C/W

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table	3.	Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{BR(CES)}	Collector-emitter breakdown voltage	$I_{C} = 250 \mu A, V_{GE} = 0$	600			V
I _{CES}	Collector cut-off (V _{GE} = 0)	V _{CE} = Max rating, @ 25°C V _{CE} = Max rating, @ 125°C			500 5	μA mA
I _{GES}	Gate-emitterleakage current (V _{CE} = 0)	$V_{GE} = \pm 20V$, $V_{CE} = 0$			±100	nA
V _{GE(th)}	Gate threshold voltage	$V_{CE} = V_{GE}, I_C = 250 \mu A$	3		5	V
V _{CE(sat)}	Collector-emitter saturation voltage	$V_{GE} = 15V, I_C = 100A$ $V_{GE} = 15V, I_C = 150A, @ 100^{\circ}C$		1.2 1.2	1.6	V V
9 _{fs}	Forward transconductance	$V_{CE} = 15V_{,}I_{C} = 100A$		80		S

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{ies} C _{oes} C _{res}	Input capacitance Output capacitance Reverse transfer capacitance	V _{CE} = 25V, f = 1MHz, V _{GE} = 0		1560 0 1100 95		pF pF pF
Q _g Q _{ge} Q _{gc}	Total gate charge Gate-emitter charge Gate-collector charge	V _{CE} = 480V, I _C = 100A, V _{GE} = 15V		560 70 170		nC nC nC
I _{CL}	Latching current	V _{clamp} = 480V Tj = 125°C , R _G = 10Ω	300			A

	• · · · · · · · · · · · · · · · · · · ·					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Delay time	$I_{\rm C} = 100{\rm A}$, $V_{\rm CC} = 480{\rm V}$		64		ns
t _r	Current rise time	$V_{GE} = 15V$, $R_G = 3\Omega$		112		ns
(di/dt) _{on}	Turn-on current slope	Tj = 25°C <i>(see Figure 17)</i>		1840		A/µs
t _{d(on)}	Dealy time	I _C = 100A , V _{CC} = 480V		56		ns
t _r	Current rise time	$V_{GE} = 15V$, $R_G = 3\Omega$		114		ns
(di/dt) _{on}	Turn-on current slope	Tj = 125°C <i>(see Figure 17)</i>		1800		A/µs
t _c	Cross-over time	L _ 100A \/ _ 490\/		2.98		μS
t _r (V _{off})	Off voltage rise time	$I_{\rm C} = 100 {\rm A}$, $V_{\rm CC} = 480 {\rm V}$		1.7		μS
t _d (_{off})	Delay time	$V_{GE} = 15V$, $R_G = 3\Omega$		2.4		μS
t _f	Current fall time	Tj = 25°C <i>(see Figure 17)</i>		1.23		μS
t _c	Cross-over time	L _ 100A \/ _ 480\/		4.52		μS
t _r (V _{off})	Off voltage rise time	$I_{\rm C} = 100 {\rm A}$, $V_{\rm CC} = 480 {\rm V}$		2.6		μS
t _d (_{off})	Delay time	$V_{GE} = 15V$, $R_G = 3\Omega$		2.8		μS
t _f	Current fall time	Tj = 125°C <i>(see Figure 17)</i>		1.8		μS

 Table 5.
 Switching on/off (inductive load)

Table 6. Switching energy (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Eon ⁽¹⁾	Turn-on switching losses	V _{CC} = 480V, I _C = 100A		11.7		mJ
E _{off} ⁽²⁾	Turn-off switching loss	R _G = 3Ω, V _{GE} = 15V, Tj= 25°C		59		mJ
E _{ts}	Total switching loss	(see Figure 17)		70.7		mJ
Eon ⁽¹⁾	Turn-on switching losses	V _{CC} = 480V, I _C = 100A		12		mJ
E _{off} ⁽²⁾	Turn-off switching loss	R _G = 3Ω, V _{GE} = 15V,		92		mJ
E _{ts}	Total switching loss	Tj= 125°C <i>(see Figure 17)</i>		104		mJ

1. Eon is the turn-on losses when a typical diode is used in the test circuit in Figure 17

2. Turn-off losses include also the tail of the collector current.



Figure 1.

2.1 Electrical characteristics (curves)

Output characteristics

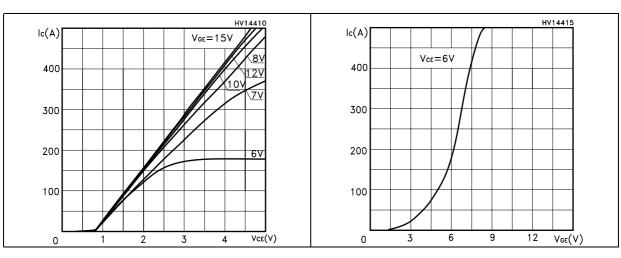


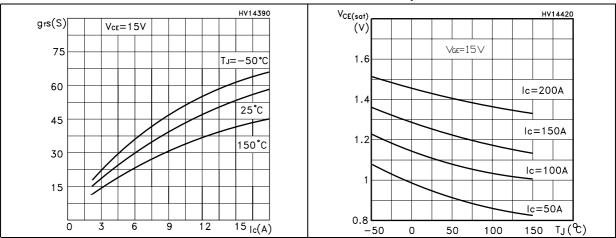
Figure 2.



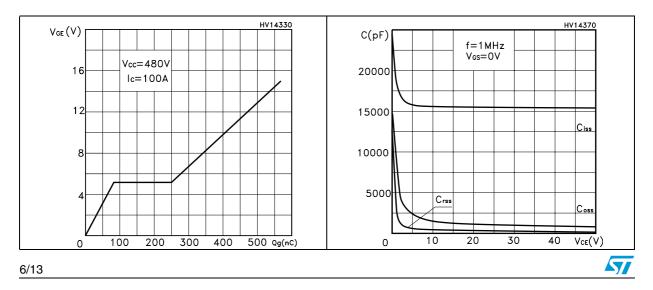
Fi

Figure 4. Collector-emitter on voltage vs temperature

Transfer characteristics







5

Figure 7. Normalized gate threshold voltage Figure 8. vs temperature

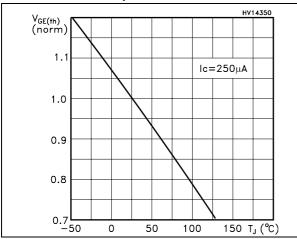
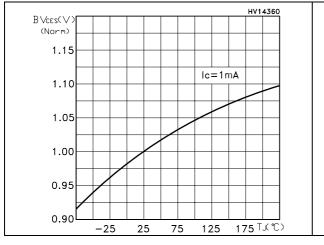
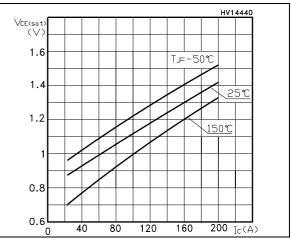
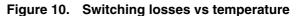


Figure 9. Normalized breakdown voltage vs temperature



e 8. Collector-emitter on voltage vs collector current





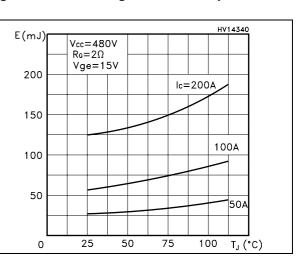
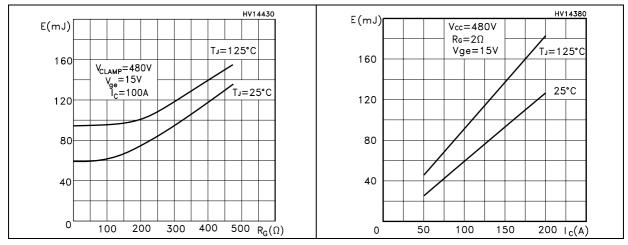


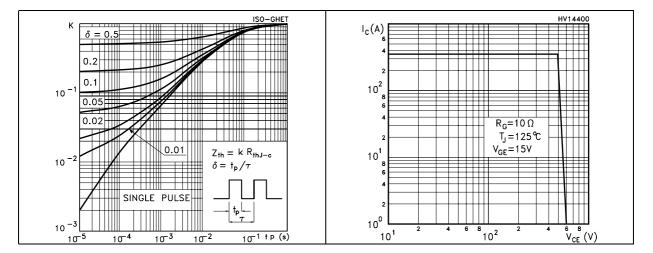
Figure 11. Switching losses vs gate resistance Figure 12. Switching losses vs collector current



7/13

Figure 13. Thermal impedance

Figure 14. Turn-off SOA





3 Test circuit

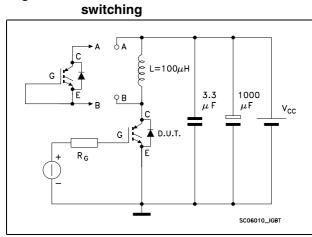


Figure 15. Test circuit for inductive load Figure 16. Gate charge test circuit switching

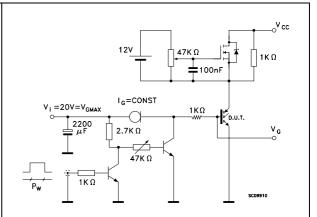
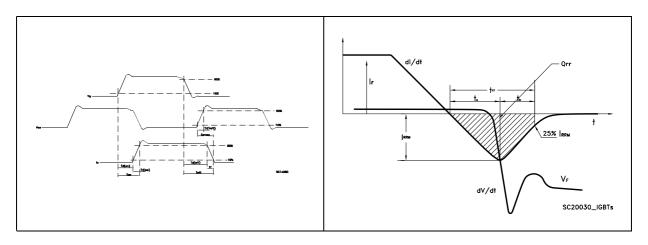


Figure 17. Switching waveform







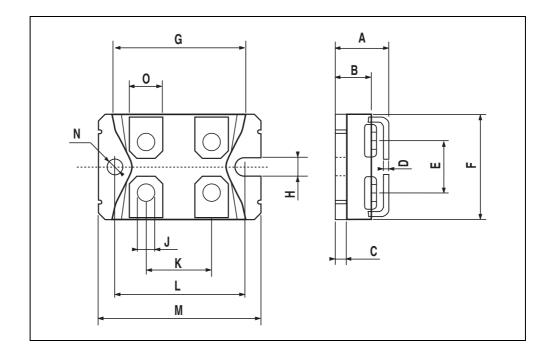
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	11.8		12.2	0.466		0.480
В	8.9		9.1	0.350		0.358
С	1.95		2.05	0.076		0.080
D	0.75		0.85	0.029		0.033
Е	12.6		12.8	0.496		0.503
F	25.15		25.5	0.990		1.003
G	31.5		31.7	1.240		1.248
Н	4			0.157		
J	4.1		4.3	0.161		0.169
К	14.9		15.1	0.586		0.594
L	30.1		30.3	1.185		1.193
М	37.8		38.2	1.488		1.503
Ν	4			0.157		
0	7.8		8.2	0.307		0.322

ISOTOP MECHANICAL DATA





5 Revision history

Date	Revision	Changes	
28-Feb-2005	6	Complete version	
26-Jul-2006	7	New template	
03-Nov-2006	8	New value inserted on Table 1.: Absolute maximum ratings	



Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZED ST REPRESENTATIVE, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2006 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan -Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

